| | Sheet | 1 | of | 1 |
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| Substitute Form PTO-1449 (Modified) U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant (Use several sheets if necessary) | | | Application No. 10/639,612 | |
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| | | Applicant Gregg D. Wilensky | | |
| | | Filing Date | Group Art Unit | |
| (37 CFR §1.98(b)) | | August 11, 2003 | 2624 | |

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| Initial | ID | Number | Date | Patent Office | Class | Subclass | Yes | No |
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| Examiner Signature | Date Considered |
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| EXAMINER: Initials citation considered. Draw line through citation if no | t in conformance and not considered. Include copy of this form with |

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